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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes -Number 4 -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
MDN		EP 1 094 424 A2	04/25/2001	HITACHI, LTD.			

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)	
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EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
MDN		K. MIYAZAKI et al., "A Method for Evaluating Reliability of Digital Signature Schemes with Linking Structure", PSJ Signotes Computer Security Abstract, July 28, 2002, XP002265338, page 1.
MDN		N. ASOKAN et al., "Server-Supported Signatures", Proceedings of the European Symposium on Research in Computer Security (ESORICS), Springer Verlag, Berlin, DE, September 1996, XP000972234, pages 131-143.
MDN		Xuhua DING et al., "Experimenting with Server-Aided Signatures", Internet Soc. Ninth Annual Symposium on Network and Distributed System Security, February 8, 2002 XP002265339, pages 1-15.

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